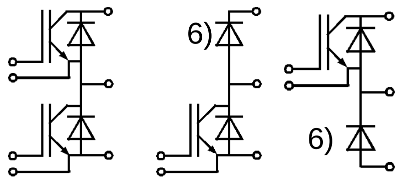
Absolute Maximum Ratings Symbol	Conditions [1]	Values		Units
V_{CES}		1200		V
V_{CGR}	R_{GE} = 20 kΩ	1200		V
I_C	T_{case} = 25/80 °C	145 / 110		A
I_{CM}	T_{case} = 25/80 °C; t_p = 1 ms	290 / 220		A
V_{GES}		± 20		V
P_{tot}	per IGBT, T_{case} = 25 °C	830		W
T_j, (T_{stg})		– 40 . . .+150 (125)		°C
V_{isol}	AC, 1 min.	2 500 [7]		V
humidity	DIN 40 040	Class F		
climate	DIN IEC 68 T.1	40/125/56		
Inverse Diode			FWD [6]	
I_F= – I_C	T_{case} = 25/80 °C	130 / 90	170 / 115	A
I_{FM}= – I_{CM}	T_{case} = 25/80 °C; t_p = 1 ms	300 / 220	300 / 220	A
I_{FSM}	t_p = 10 ms; sin.; T_j = 150 °C	1100	1450	A
I^2t	t_p = 10 ms; T_j = 150 °C	6000	10 500	A^2s

Characteristics Symbol	Conditions [1]	min.	typ.	max.	Units
$V_{(BR)CES}$	V_{GE} = 0, I_C = 4 mA	≥ V_{CES}	–	–	V
$V_{GE(th)}$	V_{GE} = V_{CE}, I_C = 4 mA	4,5	5,5	6,5	V
I_{CES}	V_{GE} = 0, T_j = 25 °C	–	0,2	2	mA
	V_{CE} = V_{CES}, T_j = 125 °C	–	9	–	mA
I_{GES}	V_{GE} = 20 V, V_{CE} = 0	–	–	1	µA
V_{CEsat}	I_C = 100 A, V_{GE} = 15 V;	–	2,5(3,1)	3(3,7)	V
V_{CEsat}	I_C = 150 A, T_j = 25 (125) °C	–	3(3,8)	–	V
g_{fs}	V_{CE} = 20 V, I_C = 100 A	54	–	–	S
C_{CHC}	per IGBT	–	–	350	pF
C_{ies}	V_{GE} = 0	–	6,5	8,5	nF
C_{oes}	V_{CE} = 25 V	–	1000	1500	pF
C_{res}	f = 1 MHz	–	500	600	pF
L_{CE}		–	–	30	nH
$t_{d(on)}$	V_{CC} = 600 V	–	160	320	ns
t_r	V_{GE} = +15 V, - 15 V [3]	–	80	160	ns
$t_{d(off)}$	I_C = 100 A, ind. load	–	400	520	ns
t_f	R_{Gon} = R_{Goff} = 6,8 Ω	–	70	100	ns
E_{on} [5]	T_j = 125 °C	–	16	–	mWs
E_{off} [5]		–	12	–	mWs
Inverse Diode [8]					
V_F = V_{EC}	I_F = 100 A, V_{GE} = 0 V;	–	2,0(1,8)	2,5	V
V_F = V_{EC}	I_F = 150 A, T_j = 25 (125) °C	–	2,25(2,1)	–	V
V_{TO}	T_j = 125 °C	–	–	1,2	V
r_T	T_j = 125 °C	–	8	11	mΩ
I_{RRM}	I_F = 100 A; T_j = 25 (125) °C [2]	–	35(50)	–	A
Q_{rr}	I_F = 100 A; T_j = 25 (125) °C [2]	–	5(14)	–	µC
FWD of type "GAL" and "GAR" [8] [6]					
V_F = V_{EC}	I_F = 100 A, V_{GE} = 0 V;	–	1,9(1,7)	2,4	V
V_F = V_{EC}	I_F = 150 A, T_j = 25 (125) °C	–	2,0(1,8)	–	V
V_{TO}	T_j = 125 °C	–	–	1,2	V
r_T	T_j = 125 °C	–	–	7	mΩ
I_{RRM}	I_F = 100 A; T_j = 25 (125) °C [2]	–	40(65)	–	A
Q_{rr}	I_F = 100 A; T_j = 25 (125) °C [2]	–	5(15)	–	µC
Thermal Characteristics					
R_{thjc}	per IGBT	–	–	0,15	°C/W
R_{thjc}	per diode / FWD [6]	–	–	0,36/0,30	°C/W
R_{thch}	per module	–	–	0,05	°C/W

SEMITRANS® M
IGBT Modules

SKM 145 GB 123 D
SKM 145 GAL 123 D [6]
SKM 145 GAR 123 D [6]

SEMITRANS 2



GB GAL GAR

Features

- MOS input (voltage controlled)
- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 * I_{cnom}
- Latch-up free
- Fast & soft inverse CAL diodes[8]
- Isolated copper baseplate using DCB Direct Copper Bonding Technology
- Large clearance (10 mm) and creepage distances (20 mm).

Typical Applications: → B 6-127

- Switching (not for linear use)

1) T_{case} = 25 °C, unless otherwise specified
2) I_F = – I_C, V_R = 600 V, – di_F/dt = 1000 A/µs, V_{GE} = 0 V
3) Use V_{GEoff} = -5 ... -15 V
5) See fig. 2 + 3; R_{Goff} = 6,8 Ω
6) The freewheeling diode of the GAL and GAR types has the data of the inverse diode of SKM 200 GB 123 D
7) V_{isol} = 4000 V_{rms} on request
8) CAL = Controlled Axial Lifetime Technology.

Cases and mech. data → B6-128 SEMITRANS 2

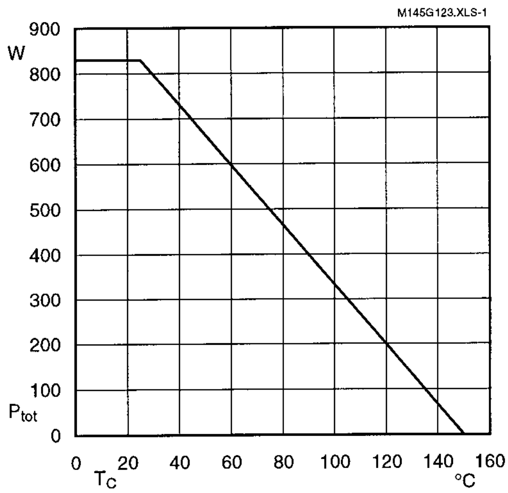
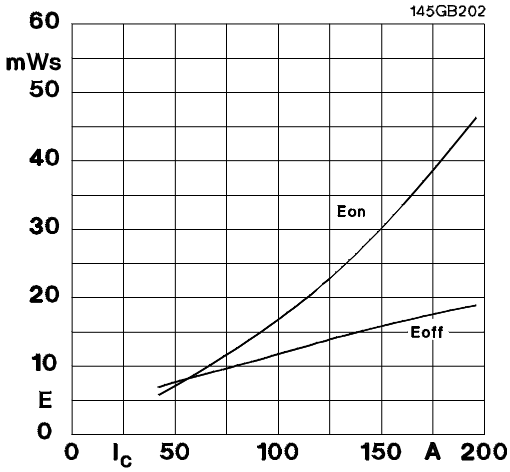
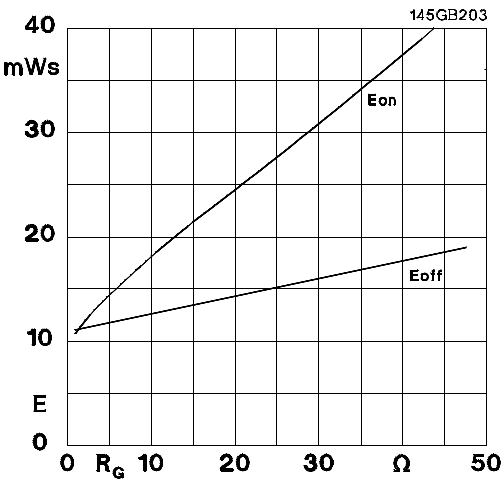


Fig. 1 Rated power dissipation P_{tot} = f (T_C)



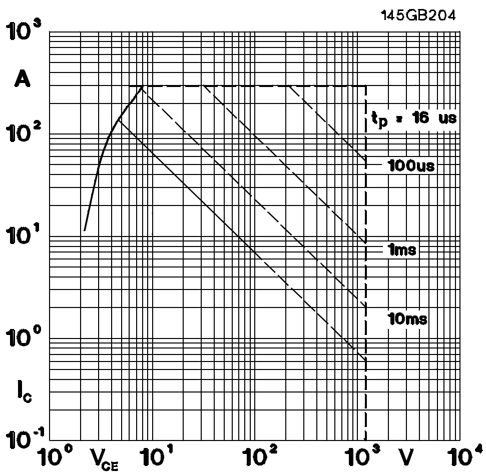
T_j = 125 °C
V_{CE} = 600 V
V_{GE} = ± 15 V
R_G = 6,8 Ω

Fig. 2 Turn-on /-off energy = f (I_C)



T_j = 125 °C
V_{CE} = 600 V
V_{GE} = ± 15 V
I_C = 100 A

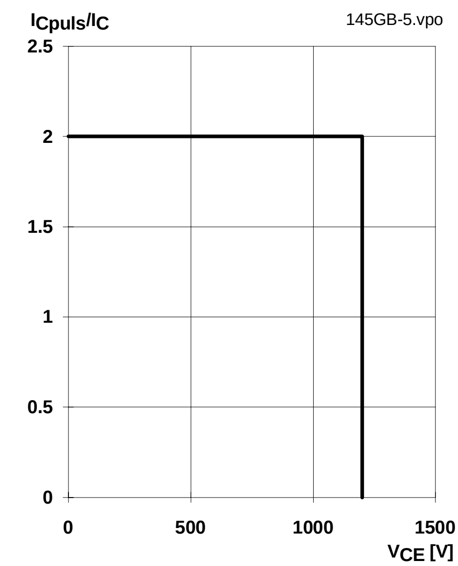
Fig. 3 Turn-on /-off energy = f (R_G)



1 pulse
T_C = 25 °C
T_j ≤ 150 °C

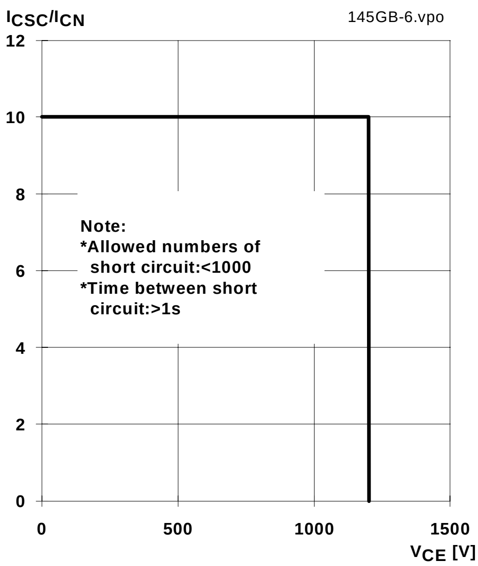
Not for linear use

Fig. 4 Maximum safe operating area (SOA) I_C = f (V_{CE})



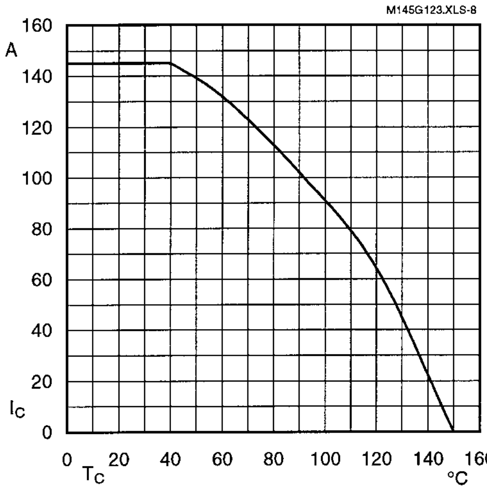
T_j ≤ 150 °C
V_{GE} = 15 V
R_{Goff} = 6,8 Ω
I_C = 100 A

Fig. 5 Turn-off safe operating area (RBSOA)



T_j ≤ 150 °C
V_{GE} = ± 15 V
t_{sc} ≤ 10 µs
L < 25 nH
I_{CN} = 100 A

Fig. 6 Safe operating area at short circuit I_C = f (V_{CE})



T_j = 150 °C
$V_{GE} \geq$ 15 V

Fig. 8 Rated current vs. temperature $I_C = f(T_C)$

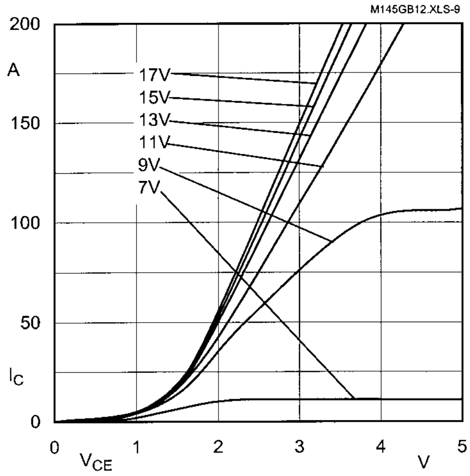


Fig. 9 Typ. output characteristic, t_p = 80 µs; 25 °C

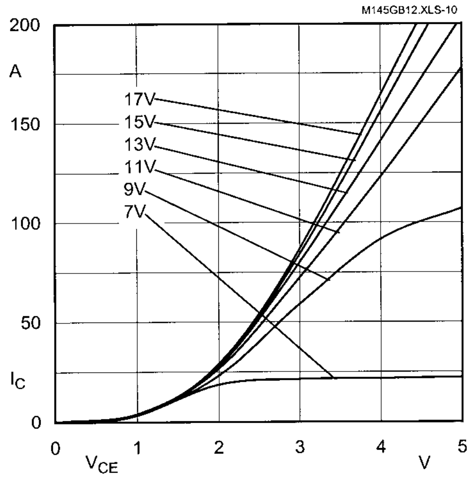


Fig. 10 Typ. output characteristic, t_p = 80 µs; 125 °C

$P_{cond(t)} = V_{CEsat(t)} \cdot I_{C(t)}$

$V_{CEsat(t)} = V_{CE(TO)(Tj)} + r_{CE(Tj)} \cdot I_{C(t)}$

$V_{CE(TO)(Tj)} \leq 1{,}5 + 0{,}002\ (T_j - 25)$ [V]

typ.: $r_{CE(Tj)} = 0{,}010 + 0{,}00004\ (T_j - 25)$ [Ω]

max.: $r_{CE(Tj)} = 0{,}015 + 0{,}00005\ (T_j - 25)$ [Ω]

valid for $V_{GE} = +15\,^{+2}_{-1}$ [V]; $I_C > 0{,}3\ I_{Cnom}$

Fig. 11 Saturation characteristic (IGBT)
Calculation elements and equations

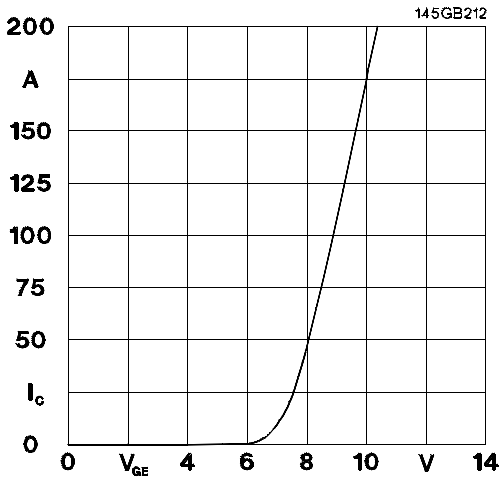
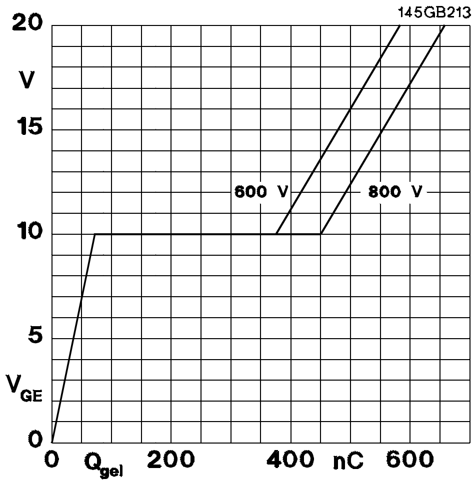
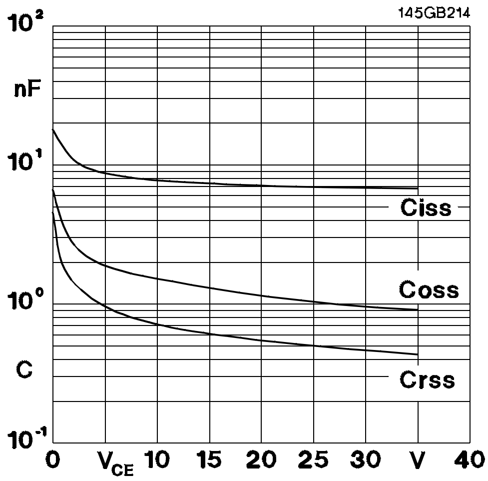


Fig. 12 Typ. transfer characteristic, t_p = 80 µs; V_{CE} = 20 V



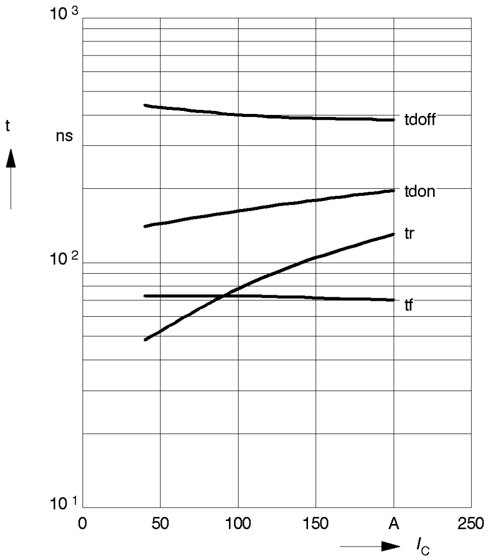
I_{Cpuls} = 100 A

Fig. 13 Typ. gate charge characteristic

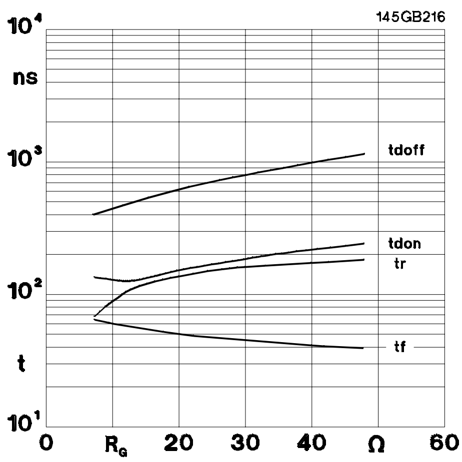


V_{GE} = 0 V
f = 1 MHZ

Fig. 14 Typ. capacitances vs.V_{CE}



T_j = 125 °C
V_{CE} = 600 V
V_{GE} = ± 15 V
R_{Gon} = 6,8 Ω
R_{Goff} = 6,8 Ω
induct. load



T_j = 125 °C
V_{CE} = 600 V
V_{GE} = ± 15 V
I_C = 100 A
induct. load

Fig. 15 Typ. switching times vs. I_C

Fig. 16 Typ. switching times vs. gate resistor R_G

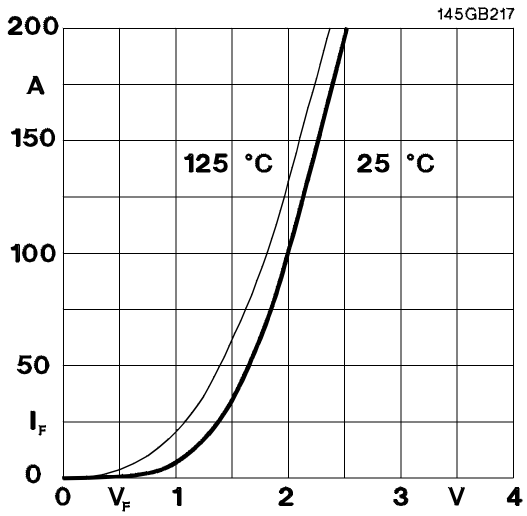


Fig. 17 Typ. CAL diode forward characteristic

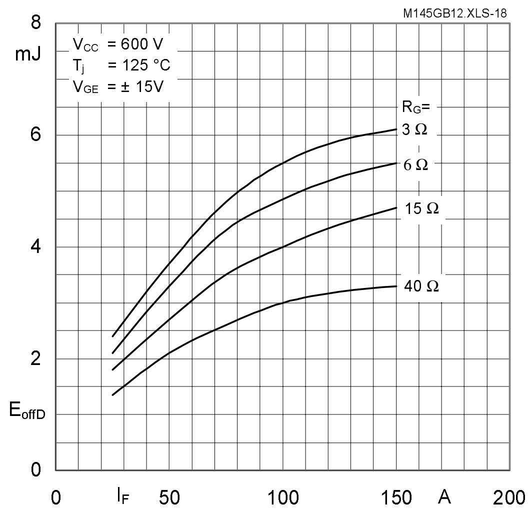


Fig. 18 Diode turn-off energy dissipation per pulse

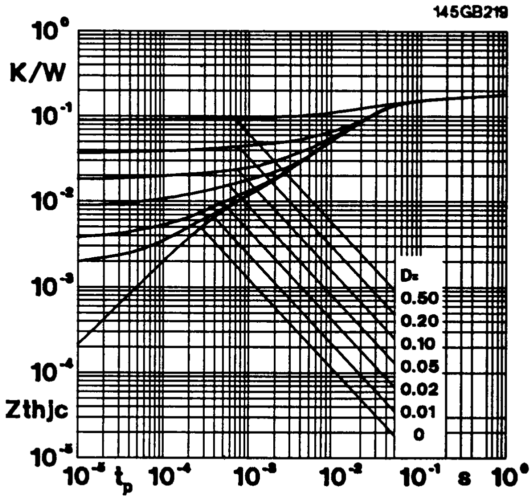


Fig. 19 Transient thermal impedance of IGBT $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

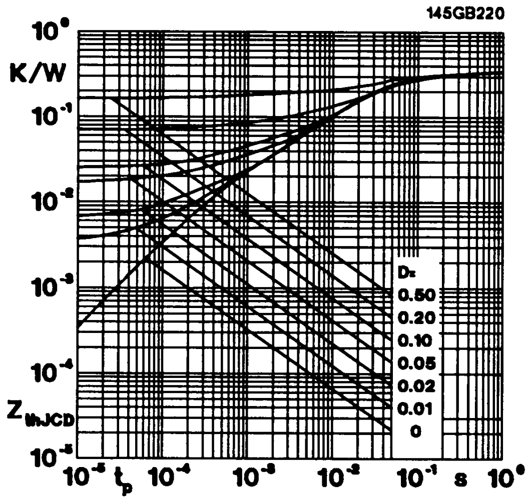


Fig. 20 Transient thermal impedance of inverse CAL diodes $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

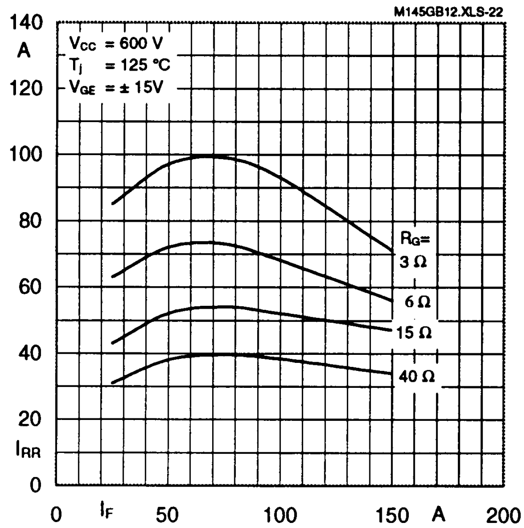


Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$

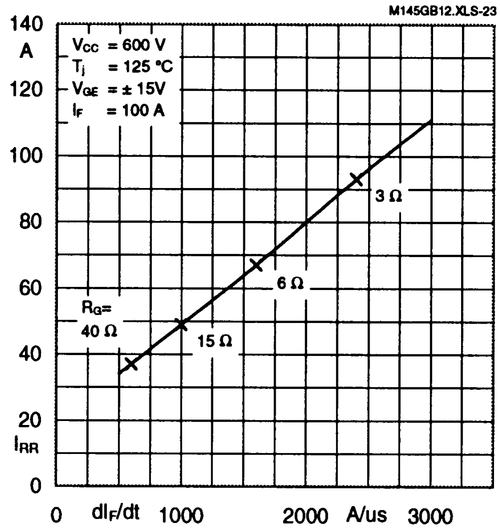


Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di/dt)$

Typical Applications include

Switched mode power supplies
DC servo and robot drives
Inverters
DC choppers (versions GAL and GAR)
AC motor speed control
Inductive heating
UPS Uninterruptable power supplies

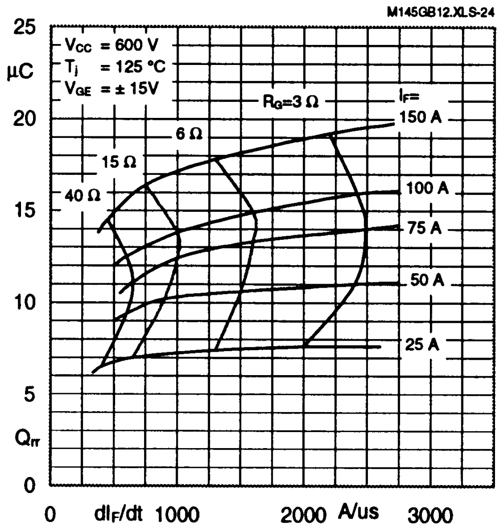


Fig. 24 Typ. CAL diode recovered charge $Q_{rr} = f(di/dt)$

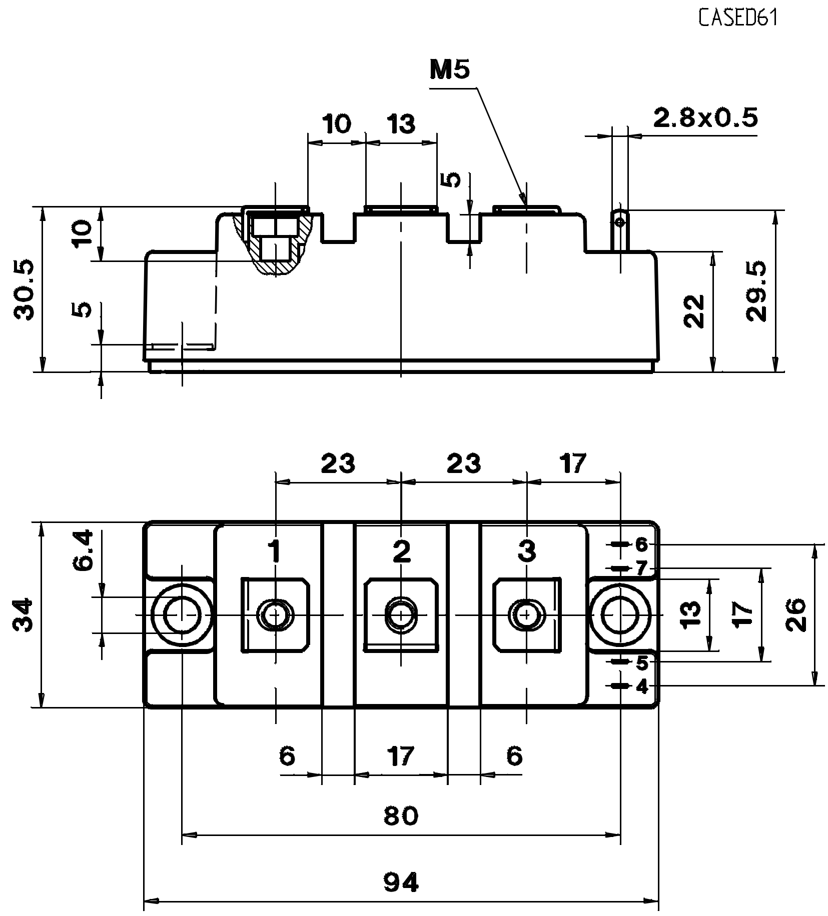
SEMITRANS 2

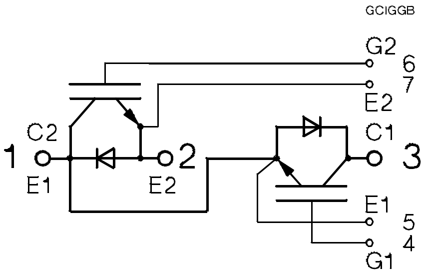
Case D 61

UL Recognized

File no. E 63 532

SKM 145 GB 123 D

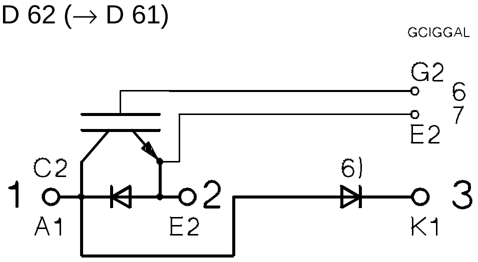




Dimensions in mm

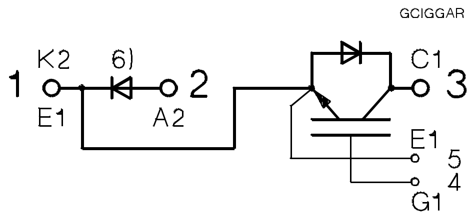
SKM 145 GAL 123 D

Case D 62 (→ D 61)



SKM 145 GAR 123 D

Case D 63 (→ D 61)



Case outline and circuit diagrams

Mechanical Data Symbol	Conditions		Values min.	typ.	max.	Units
M_1	to heatsink, SI Units	(M6)	3	–	5	Nm
	to heatsink, US Units		27	–	44	lb.in.
M_2	for terminals, SI Units	(M5)	2,5	–	5	Nm
	for terminals US Units		22	–	44	lb.in.
a			–	–	5x9,81	m/s^2
w			–	–	160	g

6) Freewheeling diode → B 6 – 123, remark 6.

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Eight devices are supplied in one SEMIBOX A without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 2). Larger packing units of 20 and 42 pieces are used if suitable

Accessories → B 6 - 4.
SEMIBOX → C - 1.

